

PCN#20191101000.1 Qualification of CDAT as an additional assembly site for select QFN devices Change Notification / Sample Request

Date:November 22, 2019To:TOKYO ELECTRON DEVICE (DSTR) PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The proposed first ship date is indicated on page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Team (<u>PCN ww admin team@list.ti.com</u>). For sample requests or sample related questions, contact your field sales representative.

Sincerely,

PCN Team SC Business Services

20191101000.1 Change Notification / Sample Request Attachments

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	CUSTOMER PART NUMBER
TPS63001DRCR	null
TPS63001DRCT	null
TPS74801RGWT	null
TPS74901RGWT	null
SN74AVC8T245RHLR	null
TPS2113ADRBT	null
TPS51916RUKT	null
TPS63002DRCT	null
TPS74801DRCT	null
TPS2115ADRBR	null
TPS62162DSGR	null
TPS62172DSGT	null
TPS63000DRCT	null
TPS74801DRCR	null
TPS63000DRCR	null
TPS74801RGWR	null
TPS62172DSGR	null
TPS74901RGWR	null
TPS2113ADRBR	null

Technical details of this Product Change follow on the next page(s).

	mber:	2019110	1000.1				PCN D	ate:	Nov 22 2019
Title:	Qualifica	ntion of CE	DAT as a	n addition	al assembly site	for sele	ect QFN	l device	es
Custom	er Conta	ct: PCN	<u>Manager</u>	Dept:	Quality S	ervices	5		
Propose	ed 1 st Shi	p Date:	Feb 22	2 2020	Estimat A	ted Sa vailat			
Change							1		
	embly Site			Design				r Bump	
	embly Pro			Data S					Material
	embly Mat				umber change		1		Process
	hanical Sp king/Shipp			Test S				r Fab S	laterials
	king/ship	Jilly/Labe	iiriy		locess			r Fab P	
				PCN	Details		Ware		1000055
Descrip	tion of C	hange:							
s follow Group 1	. <mark>BOM co</mark>	mparisor	n:			1			
					MLA	ļ	CD		
		ompound			4208625		4222		
	Mount	Compound	1		4205846		4207	123	
Group 2	BOM co	mparisor	n:						
				MLA	Clar	k		CDAT	
	Mold C	Compound		420862	4208625		4222198		
	Mount	Compoun	d	420584	6 42077	68	42	207123	
Group 3	BOM co	mparisor	n:						
					MLA		CD	AT	
	Mold Co	ompound			4208625		4222	198	
		Compound	d		4212088		4207		
	BOM co	mparisor	1:		MLA		CD	AT	
Group 4						1	-		
Group 4	Mold Co	ompound			4208625		4222	198	
Group 4	-	ompound Compound	d		4208625 4207768		<u>4222</u> 4207		
	Mount	Compound	d						
Reason	Mount (Compound Ige:	1						
Reason Continuit	Mount of for Chan ty of Supp	Compound Ige: Dly			4207768		4207	123	
Reason Continuit Anticipa	Mount of for Chan ty of Supp	Compound Ige: Dly		, Function		iabilit	4207	123	negative):
Reason Continuit Anticipa None	Mount of for Chan ty of Supp ated impa	Compound ige: oly act on Fo	rm, Fit,		4207768 , Quality or Rel	iabilit	4207	123	negative):
Reason Continuit Anticipa None Anticipa	Mount of for Chan ty of Supp ated impa	Compound age: oly act on Fo act on Ma	rm, Fit, ater <u>i</u> al I	Declaratio	4207768 , Quality or Rel		4207 y (pos	123	
Reason Continuit Anticipa None Anticipa	Mount of for Chan ty of Supp ated impa	Compound age: oly act on Fo act on Ma o the	rm, Fit, aterial I Ma frc pro rej	Declaration Interial Declor Interial Declor Interial Declor Interial Declaration Interial Dec	4207768 , Quality or Rel	ict Con be ava ductior e site li	4207 y (pos tent re ailable n relea nk belo	eports a followir se the row	re driven ng the revised

Changes to product identification resulting from this PCN:							
Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	Assembly City				
MLA	MLA	MYS	Chengdu				
CLARK	CLARK QAB PHL Angeles City, Pampan						
CDAT	CDA	CHN	Chengdu				

Sample product shipping label (not actual product label)



Product Affected:

74AVC8T245RHLRG4	TPS2115ADRBR	TPS63000DRCR	TPS63001DRCRG4
HPA00720RHLR	TPS2115ADRBT	TPS63000DRCRG4	TPS63001DRCT
SN74AVC8T245RHLR	TPS2115ADRBTG4	TPS63000DRCT	TPS63002DRCR
TPS2113ADRBR	TPS53321RGTR	TPS63000DRCTG4	TPS63002DRCT
TPS2113ADRBT	TPS53321RGTT	TPS63001DRCR	TPS63002DRCTG4
Group 2 Device List TPS74801DRCR	Current MLA Assem	bly & Clark, add CDA TPS74801RGWTG4	TPS74901RGWR
-			
TPS74801DRCRG4	TPS74801RGWRG4	TPS74901DRCR	TPS74901RGWT
TPS74801DRCT	TPS74801RGWT	TPS74901DRCT	TPS74901RGWTG4
TPS74801DRCTG4			
Group 3 Device List	(Current MLA Assem	bly, add CDAT):	
TPS62162DSGR	TPS62162DSGT	TPS62172DSGR	TPS62172DSGT
Group 4 Device List	(Current MLA Assem	bly, add CDAT):	

Group 1 Qual Memo:



TI Information Selective Disclosure

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: <u>E58T245RHLR</u>	QBS Package Reference: <u>BQ24196RGER</u>	QBS Package Reference: <u>BQ29200DRBR</u>	QBS Package Reference: <u>SN74AXC8T245RHLR</u>	QBS Package Reference: <u>TP S3850G09DRC</u>	QBS Package Reference: <u>TP S62140RGTR</u>	QBS Package Reference: <u>TRS3122ERGER</u>	QBS Package Reference: <u>UCC27282DRC</u>
AC	Autoclave 121C	96 Hours	-	3/231/0	3/231/0	-	3/231/0	3/231/0	3/231/0	3/231/0
ED	Electrical Characterization	Per Datasheet Parameters	-	-	-	Pass	Pass	Pass	Pass	Pass
FLAM	Flammability (IEC 695-2-2)								3/15/0	
FLAM	Flammability (UL 94V-0)								3/15/0	
FLAM	Flammability (UL-1694)								3/15/0	
HAST	Biased HAST, 110C/85%RH	26 Hours	-	-	-	-	-	-	-	1/77/0
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	-	3/231/0	-	3/231/0	2/154/0
HTOL	Life Test, 140C	480 Hours	-	-	-	-	-	-	-	3/231/0
HTOL	Life Test, 150C	300 Hours	-	-	-	-	1/77/0	-	1/77/0	-
HTSL	High Temp Storage Bake 150C	1000 Hours	-	-	-	3/231/0	-	-	3/231/0	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	-	-	3/231/0	-	-	-
SD	Surface Mount Solderability	Pb Free							1/22/0	
тс	Temperature Cycle, -65/150C	500 Cycles	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	-	3/231/0	-	-	-	-
WBP	Bond Pull	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0

- QBS: Qual By Similarity

QBS: Qual By Similarity
Qual Device E687245RHLR is qualified at LEVEL1-260CG
Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
The following are equivalent TESL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles
Quality and Environmental data is available at TI's external Web site: http://www.ti.com/
Green/Pb-free (SMT) and Green

Group 2 Qual Memo:



TI Information Selective Disclosure

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: TP \$74801DRCR	QBS Package Reference: <u>430F2132IRHBR</u>	QBS Package Reference: <u>BQ24196RGER</u>	QBS Package Reference: <u>BQ294504DRVR</u>	QBS Package Reference: <u>TP S51285BRUKR</u>	QBS Package Reference: <u>TRS3122ERGER</u>
AC	Autoclave 121C	96 Hours	-	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-	-	Pass
FLAM	Flammability (IEC 695- 2-2)		-	-	-	-	-	3/15/0
FLAM	Flammability (UL 94V- 0)		-	-	-	-	-	3/15/0
FLAM	Flammability (UL-1694)		-	-	-	-	-	3/15/0
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	3/231/0	-	3/231/0
HTOL	Life Test, 150C	300 Hours	-	-	-	-	-	1/77/0
HTSL	High Temp Storage Bake 150C	1000 Hours	-	-	-	-	-	3/231/0
SD	Surface Mount Solderability	Pb Free	-	-	-	-	-	1/22/0
тс	Temperature Cycle, - 65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0
WBP	Bond Pull	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0

OBS: Qual By, Similarity
 Qual Device TPS74801DRCR is qualified at LEVEL2-260C
 Preconditioning was performed for Autodave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
 The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
 The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
 The following are equivalent TTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
 The following are equivalent TTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
 The following are equivalent TTSL options per JESD47: -55C/126C/700 Cycles and -65C/150C/500 Cycles
 Quality and Environmental data is available at TI's external Web site: http://www.ti.com/
 Crean/0H.ftcse Staties

Green/Pb-free Status: Qualified Pb-Free(SMT) and Green

Group 3 Qual Memo:



TI Information Selective Disclosure

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: TP S62162DSGR	QBS Package Reference: <u>BQ294504DRVR</u>	QBS Package Reference: <u>OPA2170AIDSGR</u>	QBS Package Reference: <u>TP S53605DSQ</u>	QBS Package Reference: <u>TRS3122ERGER</u>
-	CLHTOL (FF)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/47/0	-
-	CLHTOL (FS)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/33/0	-
-	CLHTOL (SF)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/33/0	-
-	CLHTOL (SS)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/47/0	-
-	Moisture Sensitivity Level, JEDEC	Level 2-260C	3/36/0	-	-	-	-
AC	Autoclave 121C	192 Hours	-	3/231/0	-	-	-
AC	Autoclave 121C	96 Hours	-	3/231/0	-	-	3/231/0
CDM	ESD - CDM	1000 V	-	-	3/9/0	3/9/0	-
CDM	ESD - CDM	1500 V	-	-	2/6/0	2/6/0	1/3/0
CDM	ESD - CDM	250 V	-	-	3/9/0	3/9/0	-
CDM	ESD - CDM	500 V	-	-	3/9/0	3/9/0	-
CDM	ESD - CDM	750 V	-	-	3/9/0	3/9/0	-
DS	Die Shear	QSS 009-009	-	-	-	-	3/30/0
ED	Electrical Characterization	Per Datasheet Parameters	-	-	1/Pass	3/90/0	1/30/0
ED	Electrical Characterization, side by side	-	1/Pass	-	-	-	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	-	3/2999/0	-
FLAM	Flammability (IEC 695-2-2)		-	-	-	-	3/15/0
FLAM	Flammability (UL 94V-0)		-	-	-	-	3/15/0
FLAM	Flammability (UL-1694)		-	-	-	-	3/15/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	-	3/231/0	-
HAST	Biased HAST, 130C/85%RH	192 Hours	-	3/228/0	-	-	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	3/231/0	3/231/0	-	3/231/0
HBM	ESD - HBM	1000 V	-	-	3/9/0	3/9/0	-
HBM	ESD - HBM	1500 V	-	-	3/9/0	3/9/0	-

Туре	Test Name / Condition	Duration	Qual Device: TP S62162DSGR	QBS Package Reference: BQ294504DRVR	QBS Package Reference: <u>OPA2170AIDSGR</u>	QBS Package Reference: <u>TP S53605DSQ</u>	QBS Package Reference: <u>TRS3122ERGER</u>
HBM	ESD - HBM	2000 V	-	-	3/9/0	3/9/0	-
HBM	ESD - HBM	2500 V	-	-	-	3/9/0	-
HBM	ESD - HBM	3000 V	-	-	3/9/0	-	-
HBM	ESD - HBM	4000 V	-	-	3/9/0	-	1/3/0
HBM	ESD - HBM	500 V	-	-	3/9/0	2/6/0	-
HTOL	Life Test, 125C	1000 Hours	-	-	-	3/231/0	-
HTOL	Life Test, 150C	300 Hours	-	-	-	-	1/77/0
HTSL	High Temp Storage Bake 150C	1000 Hours	-	-	-	-	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	3/231/0	2/90/0	-
LU	Latch-up	(per JESD78)	-	-	-	-	1/6/0
LU	Latch-up	Latchup/125C	-	-	-	3/18/0	-
LU	Latch-up	Latchup/25c	-	-	1/6/0	-	-
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	3/Pass	3/Pass	-	3/Pass	3/Pass
MQ	Manufacturability (Assembly)	(per mfg. Site specification) Request crater check	-	-	3/Pass	-	-
MQ	Manufacturability (Testability - TQ)	(per mfg. Site specification)	-	-	-	-	1/Pass
MSL	Thermal Path Integrity	Level 1-260C	-	3/36/0	-	-	-
MSL	Thermal Path Integrity	Level 2-260C	-	-	-	-	3/36/0
MSL	Thermal Path Integrity, JEDEC, L2	Elec-2/25C	-	-	1/12/0	-	-
MSL	Thermal Path Integrity, JEDEC, L2	Level 2	-	-	2/24/0	-	-
PC	PreCon Level 2	Elec/25C	-	-	3/1249/0	11/815/0	-
PC	PreCon Level 2	Level 2-260C	-	-	-	-	3/1005/0
PD	Physical Dimensions	(per mechanical drawing)	-	-	1/5/0	3/90/0	3/30/0
SD	Pb Free Solderability	Pb Free/Solderability	-	-	-	3/15/0	-
SD	Surface Mount Solderability	Pb Free	-	-	-	-	1/22/0
тс	Temperature Cycle, - 65/150C	1000 Cycles	-	3/231/0	-	-	-
тс	Temperature Cycle, - 65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0	3/231/0
тс	Temperature Cycle, - 65/150C	750 Cycles	-	3/231/0	3/231/0	-	-
UHAST	Unbiased HAST 110C/85%RH	264 Hours	-	-	-	3/231/0	-
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	3/231/0	-	-
Туре	Test Name / Condition	Duration	Qual Device: TPS62162DSGR	QBS Package Reference: <u>BQ294504DRVR</u>	QBS Package Reference: <u>OPA2170AIDSGR</u>	QBS Package Reference: <u>TP 553605DSQ</u>	QBS Package Reference: <u>TRS3122ERGER</u>
VM	Visual / Mechanical	(per mfg. Site specification)	-	-	-	-	3/984/0
VM	Visual Quality Reliability Inspection	Post 1000 Cycles Temp Cycle	-	3/6/0	-	-	-
VM	Visual Quality Reliability	Post 192 Hours HAST	-	3/6/0	-	-	-

VM	Inspection	Post 1000 Cycles Temp Cycle	-	3/6/0	-	-	-	
VM	Visual Quality Reliability	Post 192 Hours HAST		3/6/0				
VIVI	Inspection	Post 192 Hours HAST	-	51010	-	-	-	
VM	Visual Quality Reliability	Post 96 Hours HAST		3/6/0				
VIVI	Inspection	Post of Hours HAST	-	5000	-	-	-	
VM	Visual Quality Reliability	Post Autoclave					3/Pass	
VIVI	Inspection	Post Autociave	-	-	-	-	5/1-433	
VM	Visual Quality Reliability	Post Temp Cycle					3/Pass	
VIVI	Inspection	Post reliip Cycle	-	-	-	-	J/FdSS	
WBP	Bond Pull	36 leads, 5 units/lot	-	-	-	3/228/0	-	
WBP	Bond Pull	76 Wire, 3 units min	-	-	-	-	3/228/0	
WBP	Bond Pull	Wires	3/228/0	3/228/0	-	-	-	
WBS	Ball Bond Shear	36 leads, 5 units/lot	-	-	-	3/228/0	-	
WBS	Ball Bond Shear	76 balls, 3 units min	-	-	-	-	3/228/0	
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	-	-	-	
XRAY	X-ray	(top side only)	-	-	-	-	3/15/0	

- QBS: Qual By Similarity

- QBS: Qual By Similarity - Qual Device TPS62162DSGR is qualified at LEVEL2-260CG - Preconditioning was performed for Autodave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable - The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours - The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours - The following are equivalent TTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours - The following are equivalent TTSL options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at TI's external Web site: http://www.ti.com/ Green/Pb-free Status: Qualified Pb-Free(SMT) and Green

Group 4 Qual Memo:



TI Information Selective Disclosure

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: TP \$51916RUKR	QBS Package Reference: <u>BQ294504DRVR</u>	QBS Package Reference: <u>TP S51285BRUKR</u>	QBS Package Reference: <u>TP S53605DSQ</u>	QBS Package Reference: <u>TRS3122ERGER</u>
AC	Autoclave 121C	96 Hours	-	3/231/0	3/231/0	-	3/231/0
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	Pass	Pass
FLAM	Flammability (IEC 695-2-2)		-	-	-	-	3/15/0
FLAM	Flammability (UL 94V-0)		-	-	-	-	3/15/0
FLAM	Flammability (UL-1694)		-	-	-	-	3/15/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	-	3/231/0	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	3/231/0	-	-	3/231/0
HTOL	Life Test, 125C	1000 Hours	-	-	-	3/231/0	-
HTOL	Life Test, 150C	300 Hours					1/77/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	-	2/90/0	3/231/0
SD	Pb Free Solderability	Pb Free/Solderability	-	-	-	3/15/0	1/22/0
тс	Temperature Cycle, - 65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST 110C/85%RH	264 Hours	-	-	-	3/231/0	-
WBP	Bond Pull	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0

- QBS: Qual By Similarity - Qual Device TPS51916RUKR is qualified at LEVEL2-260CG

Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
 The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours - The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status: Qualified Pb-Free(SMT) and Green

For guestions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
WW PCN Team	PCN_ww_admin_team@list.ti.com

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